


<b>Search Notes</b> 	<b>Application/Control No.</b> 10782779	<b>Applicant(s)/Patent Under Reexamination</b> OWASHI ET AL.
	<b>Examiner</b> Debelie, Mitiku	<b>Art Unit</b> 2621

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
386	46	8/30/2007	MD

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor search	8/28/2007	MD

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>